Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | KROTH ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0193118 A1	12-2002	Jain et al.	455/453
*	В	US-6,738,625 B1	05-2004	Oom et al.	455/453
*	С	US-6,129,604	10-2000	Maveddat et al.	455/453
*	D	US-6,968,192 B2	11-2005	Longoni, Fabio	455/453
*	Е	US-6,577,871 B2	06-2003	Budka et al.	455/453
*	F	US-2005/0148337 A1	07-2005	Karlsson et al.	455/453
*	G	US-6,792,275 B1	09-2004	Lo et al.	455/452.2
*	Н	US-6,292,667 B1	09-2001	Wallentin et al.	455/458
*	ı	US-6,553,233 B1	04-2003	Lee et al.	455/446
*	J	US-6,671,259 B1	12-2003	He et al.	370/238
*	К	US-2003/0112752 A1	06-2003	Irifune et al.	370/229
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	8	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.